Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/731,289	NIKI ET AL.	
Examiner	**Art Unit**	
John Juba, Jr.	2872	

SEARCHED			
Class	Subclass	Date	Examiner

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
EAST text search notes attached, including text search of 242/160.1 and 242/160.4	6/23/2005	
Excerpts from JIS B 0601 & JIS B 0031 attached	6/23/2005	
100S corres. to about 12.5 ~ 25 micron Ra with Ry max of 100 micron	6/23/2005	
Google™ "roll surface" and films and roughness	6/23/2005	
Roundedness and cylindricality defined at SPEC Pg. 7, lines 6 - 11	6/23/2005	